

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/647,480	SATO ET AL.	
Examiner	Art Unit	
Quang N. Nguyen	2141	

SEARCHED					
Class	Subclass	Date	Examiner		
709	206	5/10/2007	QN		
709	220	5/10/2007	QN		
709	223	5/10/2007	QN		
709	245	5/10/2007	QN		
348	207.2	5/11/2007	QN		
709	203	9/23/2007	QN .		
709	217-219	9/23/2007	QN		
709	223-226	9/23/2007	QN		
709	229	9/23/2007	QN		
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TMI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
709	203	9/23/2007	QN		
709	217	9/23/2007	QN		
709	218	9/23/2007	QN		
709/2	25, 229	9/23/2007	QN		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Inventor Name Search	5/10/2007	QN	
East Search (see notes)	5/11/2007	QN	
East Search (see notes)	9/23/2007	QN	
IEEE Search (see notes)	9/23/2007	QN	
Google Search (see notes)	9/23/2007	QN	